

**Search Notes**

Application/Control No.

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Examiner

Shin-Lin Chen

Applicant(s)/Patent under  
Reexamination

LI ET AL.

Art Unit

1632

**SEARCHED**

Class	Subclass	Date	Examiner
Updated		9/20/2006	<i>SLC</i>

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated	9/20/2006	<i>SLC</i>